# product specification 产品规格书

Project No.	CTW-24097H10-HD
项目编号	
Customer	
客户名称	
Module No.	
客户型号	
Product type	StandardLCM
产品内容	240*320 2.4 "TFT LCD

Customer Approval				
Project Manager				
Director of Quality				
Purchasing Engineer				

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#### **REVISION HISTORY**

Rev	Description	Page	Date
1.0	Initial Release		

## 1. GENERAL DESCRIPTION

#### 1.1 **DESCRIPTION**

CTW24097H1-HD0 is a transmissive type color active matrix TFT (Thin Film Transistor) liquid crystal display (LCD) that uses amorphous silicon TFT as a switching device. This model is composed of a TFT-LCD module (TFT-LCD panel, driver IC and FPC), a back-light unit and. The resolution of 2.4"

contains 240 RGB X320 pixels and can display up to 262k colors.

Items	Specification	Unit	Note
Drive element	a-Si TFT	-	-
LCM outline size	42.72 (H) x 60.26 (V)	mm	
Active area	36.72 (H) x 48.96 (V)	mm	-
Number of pixels	240(H)X320(V)	pixels	-
Pixel arrangement	RGB stripe	-	-
Pixel Pitch	0.153x 0.153	mm	-
Display color	262k	color	-
Viewing direction	12 o'clock	-	-
Controller / Driver	ST7789T3	-	-
Data interface	SPI 4W	-	
Backlight	4 White LEDs In Parallels	I	
Weight	TBD	g	

#### 1.2 GENERAL INFORMATION

## 2. ABSOLUTE MAXIMUM RATING

(Ta=25±2°C, Vss=GND=0V)

Characteristics	Symbol	Min.	Тур	Max.	Uni t	Notes
Supply Voltage	IOVCC	-0.3	-	4.6	V	
Supply Voltage	VCI	-0.3	-	4.6	V	
TFT Gate On voltage	VGH	-0.3	-	30	V	
TFT Gate Off voltage	VGL	-0.3	-	30	V	
Backlight Forward Current	l <sub>F</sub>	-		80	mA	
Operating Temperature	T <sub>OPR</sub>	-20		+70	°C	(1), (3)
Storage Temperature	T <sub>STG</sub>	-30		+80	°C	(2), (3)
Humidity	RH	-		90	%	Max. 60 °C

Notes:

- (1) In case of below 0°C, the response time of liquid crystal (LC) becomes slower and the color of panel becomes darker than normal one. Level of retardation depends on temperature, because of the LC characteristics.
- (2) If product is exposed to high temperatures for extended time, there is a possibility of the polarizer film damage which could degrade the optical characteristics.
- Permanent damage to the device may occur if maximum values are exceeded or reverse voltage is loaded.
  Functional operation should be restricted to the conditions described under normal

Functional operation should be restricted to the conditions described under no operating conditions.

## 3. ELECTRICAL CHARACTERISTICS

#### 3.1 LCM DC CHARACTERISTICS

1	Ta=25±2°	$\sim$
(	Ta-zo±z	U)

Characteristics	Symbol	Min.	Тур.	Max.	Unit	Note
Power Supply Voltage 1	IOVCC	1.65	-	3.3	V	
Power Supply Voltage 2	VCI	2.5	-	3.3	V	
Power Supply Voltage 3	-	-	-	-	V	
Power Supply for MTP	VPP	-	-	-	V	
Current Concurrention	I <sub>DD</sub>	-	TBD	-	mA	Normal mode
Current Consumption	I <sub>DD-SLEEP</sub>		TBD		uA	Sleep mode
Input voltage "L" Level	VIL	GND	-	0.3IOVCC	V	IOVCC=1.65~
Input voltage "H" Level	Vih	0.7IOVCC	-	IOVCC	V	3.3
Output voltage "L" Level	V <sub>oL</sub>	0	-	0.2IOVCC	V	l <sub>o∟</sub> =1mA
Output voltage "H" Level	V <sub>оН</sub>	0.8IOVCC	-	IOVCC	V	I <sub>OH</sub> =-1mA

#### 3.2 BACK-LIGHT UNIT CHARACTERISTICS

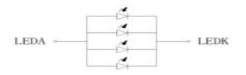
The back-light system is an edge-lighting type with 4 white LEDs. The characteristics of the back-light are shown in the following tables.

	-			-		(	Ta=25±2°C)
Characteristics	Symbol	Condition	Min.	Туре	Max.	Unit	Notes
Forward Voltage	Vf	I∟=80mA	2.8	-	3.0	V	-
Forward current	١L		-	80	-	mA	-
Luminance	Lv	I∟=80mA	-	360		cd/m <sup>2</sup>	-
LED life time	-	l∟=80mA	20,000	25,000		Hr	Note 1

Note:

(1) The "LED life time" is defined as the module brightness decrease to 50% of original brightness at  $I_L$ =80mA. The LED life time could be decreased if operating  $I_L$  is larger than 80mA.

Bcklight circuit diagram shown in below:



Vf=3.0V, If=80mA

背光电路图 (CIRCUIT DIAGRAM)

## 4. OPTICAL CHARACTERISTICS

The following items are measured under stable conditions. The optical characteristics should be measured in a dark room.

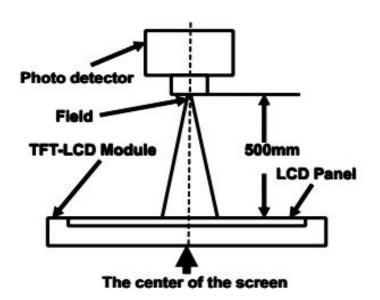
Measuring equipment: BM-5AS, BM-7, EZ-Contrast.

								(Ta=25±2°C)
Paramet	ter	Symbol	Condition	Min.	Тур.	Max.	Unit	Note
Contrast F (Center po		C/R	-	-	250	-	-	BM-7 Note(2)
Luminance o (Center po		L <sub>w</sub>	B/L on	15%	TBD	15%	cd/m <sup>2</sup>	CA-210
Luminance ur	niformity	Uw		83	-	-	%	BM-7 Note(3)
Response	Time	Tr + Tf		-	30	-	ms	BM-5AS Note(4)
	White	Wx	θ = 0.	0.288	0.308	0.328		
	vvnite	Wx	Normal viewing	0.305	0.325	0.345	_	CA-210 Note(5)
		R <sub>x</sub>	angle	0.592	0.612	0.632		
Color	Red	R <sub>Y</sub>	B/L On	0.309	0.329	0.349		
Chromaticity (CIE 1931)	0	G <sub>X</sub>	Note(1)	0.279	0.299	0.319		
· · · /	Green	Gy		0.547	0.567	0.587		
	Dhu	Bx		0.124	0.144	0.146	1	
	Blue	By		0.090	0.110	0.130		
		θτ		-	45	-		
Viewing	Angle	$\theta_{B}$		-	20	-		EZ Contrast
Angle		θι	C/R≥10	-	45	-	Deg	Note(6)
	Ver.	θ <sub>R</sub>		-	45	-		
Optima \	/iew Dire	ction			ALL	-	-	Note(7)

\* This condition will be changed by the evaluation circumstance. If product is exposed to high temperatures for extended time, there is a possibility of the polarizer film damage which could degrade the optical characteristics.

Notes:

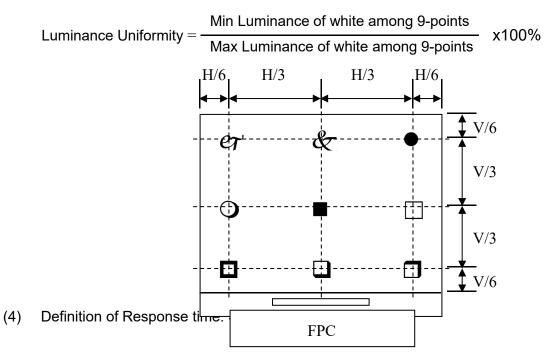
(1) Test Equipment Setup: After stabilizing and leaving the panel alone at a given temperature for 30min, the measurement should be executed. Measurement should be executed in a stable, windless, and dark room 30min after lighting the back-light. This should be measured in the center of screen.



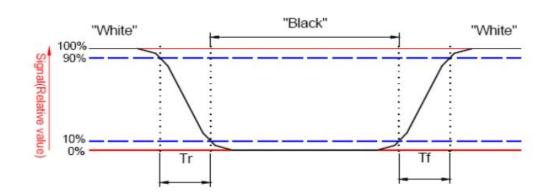
(2) Definition of Contrast Ratio (CR):

Contrast Ratio (CR) = Luminance measured when LCD on the "white" state Luminance measured when LCD on the "black" state

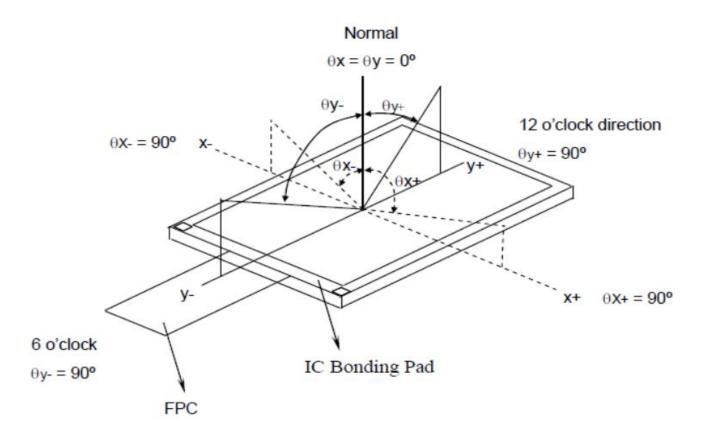
(3) Definition of Luminance Uniformity: Active area is divided into 9 measuring areas (Shown in below), every measuring point is placed at the center of each measuring area.



The spot locations for luminance measurement

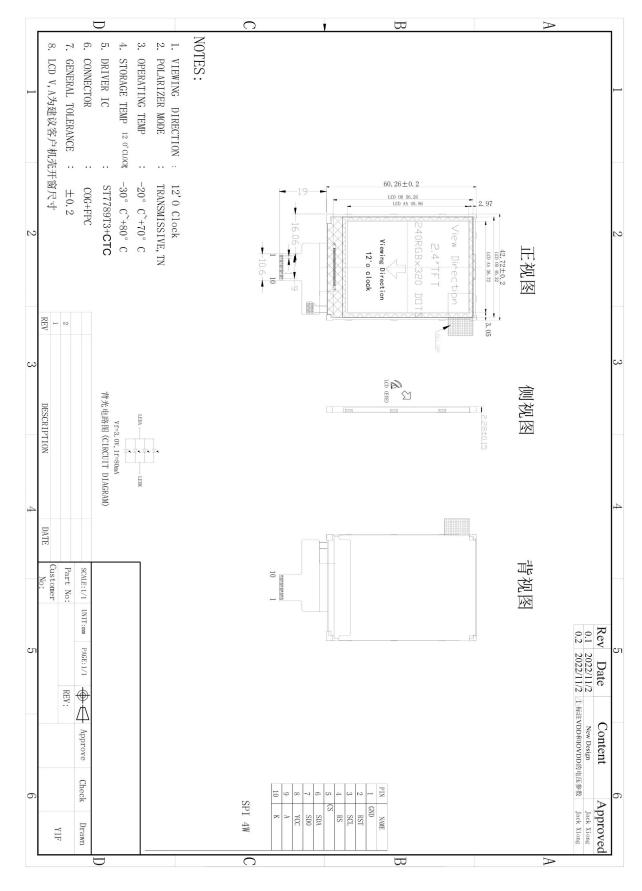


(5) Definition of Viewing Angle: The viewing angle range that the  $CR \ge 10$ .



- (6) Definition of Color Chromaticity (CIE 1931)Color coordinate of white & red, green, blue at center point.
- (7) The different Rubbing Direction will cause the different optima view direction.

#### **5.MODULE OUTLINE DIMENSION**



5.

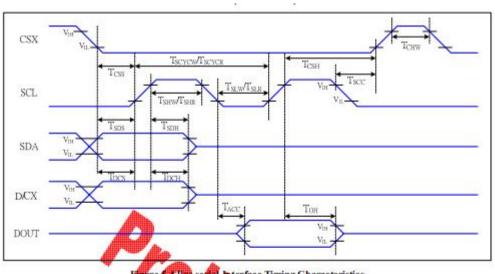
Pin No.	Symbol	Description			
1	GND	Power Ground			
2	RST	Reset input pin			
3	SCL	serial clock signal input pin.			
4	RS	Data or Command select pin in the parallel interface			
5	CS	Chip select input pin			
6	SDA	serial signal int			
7	SD0	output signal			
8	VCC	Power supply for interface logic circuits(2.8V-3.3V)			
9	A	Back-light Anode			
10	K	Back-light Cathode			

## 6. MODULE INTERFACE DESCRIPTION

## 7. REFERENCE APPLICATION CIRCUIT

Please consult our technical department for detail information.

## 8.TIMINGS FOR SPI Interface



Film serial Interface Timing Characteristics

Signal	Symbol	Parameter	MIN	MAX	Unit	Description	
	Tcss	Chip select setup time (write)	15		ns		
	Тсян	Chip select hold time (write)	15		ns		
CSX	Tcss	Chip select setup time (read)	60		ns		
	Tsoc	Chip select hold time (read)	65		ns		
	Тсни	Chip select "H" pulse width	40		ns		
T <sub>SCYCW</sub> T <sub>SHW</sub>	Tacycw	Serial clock cycle (Write)	66	~	ns	-write command & data	
	SCL "H" pulse width (Write)	15		ns	ram		
SCL	TSLW	SCL "L" pulse width (Write)	15		ns	iam	
SUL	TSCYCR	Serial clock cycle (Read)	150		ns		
TSHR	TSHR	SCL "H" pulse width (Read)	60		ns	-read command & data	
	TalR	SCL "L" pulse width (Read)	60		ns	Idili	
D/CX	TDCS	D/CX setup time	10	Ĩ.	ns		
DIGA	Трсн	D/CX hold time	10		ns		
SDA	TSDS	Data setup time	10		ns		
(DIN)	T <sub>SDH</sub>	Data hold time	10	į.	ns		
DOUT	TACC	Access time	10	50	ns	For maximum CL=30pF	
0001	Тон	Output disable time	15	50	ns	For minimum CL=8pF	

### 9.R9.ELIABILITY TEST CONDITIONS

No.	Test Item	Test Condition	Notes	
1	High Temperature Storage	+80°C / 240H	Inspection after 2~4h storage at room temperature, the sample shall be free from defects: 1. Air bubble in the LCD; 2. Seal leak;	
2	Low Temperature Storage	-30°C / 240H		
3	High Temperature Operating	+70°C / 240H		
4	Low Temperature Operating	-20°C / 240H		
5	Temperature Cycle	Ta=-10°C~+25~+50°C,10 Cycle,per30min		
6	High Temperature /Humidity storage	60°C ,90%RH / 120H	3. Non-display; 4. Missing	
7	Vibration Test	Frequency: 10Hz~55Hz~10Hz Amplitude:1.5mm, 2 hours for each direction of X, Y, Z	segments; 5.Glass crack; 6. The surface shall be free from damage.	
8	Packing Drop Test	Drop to the ground from 1m height, 1 corner, 3 edges, 6 surfaces.		
9	ESD test	Voltage:±8KV R: 330Ω C: 150pF Air discharge, Three or five times.	7. The electrical characteristics requirements shall be satisfied.	

#### Remarks:

- (1) The test samples should be applied to only one test item.
- (2) Sample size for each test item is 5~10pcs.
- (3) For High Temperature/Humidity storage test, pure water (resistance>10M $\Omega$ ) should be used.
- (4) In case of malfunction defect caused by ESD damage, if it would be recovered to normal state after resetting, it would be judge as a good part.
- (5) Failure judgment criterion: basic specification, electrical characteristic, mechanical characteristic, optical characteristic.

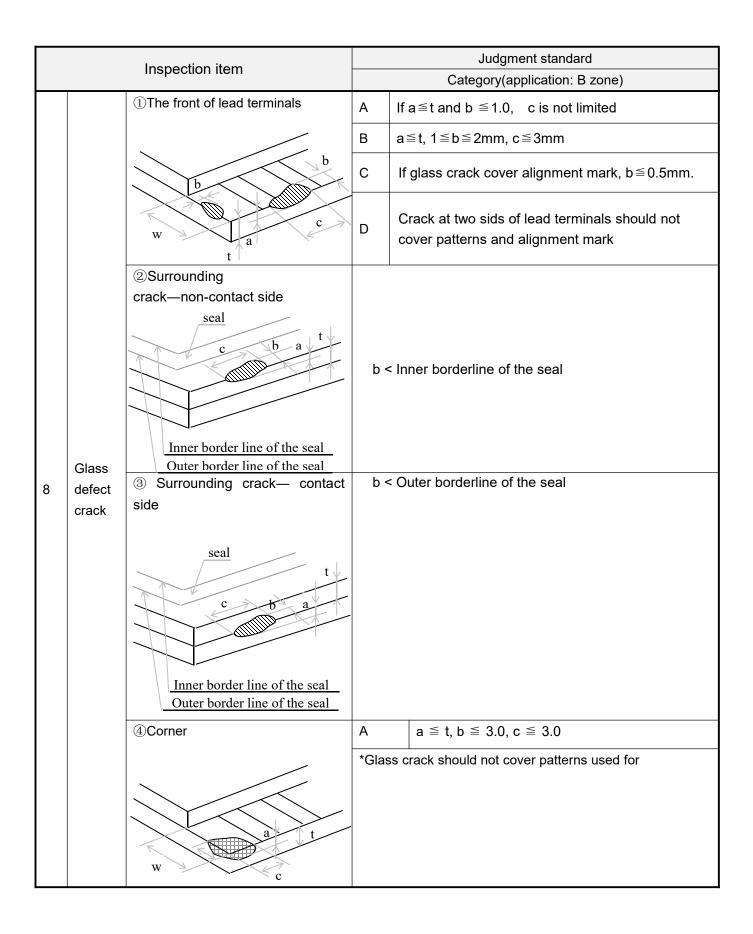
#### **10.PACKING SPECIFICATION**

TBD

## **11.INSPECTION CRITERION**

				Judgement stan	dard	
Inspection item				Acceptable number		
			Category	A zone	B zone	
1	Black spot, White spot, Bright Spot, Pinhole Foreign Particle, Bubble and Particle Between polarizer and $\Phi = (a+b)/2(mm)$ glass, scratch on polarizer		A B C	$\begin{array}{c} \Phi \! \leq \! 0.10 \\ 0.10 \! < \! \Phi \! \leq \! 0.20 \\ \Phi \! > \! 0.2 \end{array}$ Total defective point(B,C)	lgnored 2 0 3	Ignored
		Bright spot		0.15<Φ≦0.20	N≪2	Ignored
	Pixel point defect	Dark spot/ Black spot		0.15<Φ≦0.20	N≪2	
		Attached to the two pixels are bright spots		0.15<Φ≦0.20	N≪2	
		Even a two pixel is dark		0.15<Φ≦0.20	N≤2	
		Pixel total number		0.15<Φ≦0.20	N≤2	
		Note1: the spot defect caused by foreign matter is judged according to the defect of the foreign body. Note 2: when the light is not wired to show the type of defects.				
2	Black line, White line, Bubble and Particle Between Polarizer and glass, Scratch on polarizer	W	A B C	W≦0.03 L≦3.0 0.03 <w≦0.05 l≦3.0<br="">0.05<w< td=""><td>Ignored 2 0</td><td>Ignored</td></w<></w≦0.05>	Ignored 2 0	Ignored
		L W:Width, L:Length(mm)		Total defective point(B,C)	2	
3	Contrast variation	b	A B C	$\begin{array}{c} \Phi \! \leq \! 0.1 \\ 0.1 \! < \! \Phi \! \leq \! 0.3 \\ \Phi \! > \! 0.3 \end{array}$	lgnored 2 0	Ignored
		$\begin{array}{   } \hline & a \\ \hline & \Phi = (a+b)/2(mm) \end{array}$		Total defective point(B,C)	2	
4	Bubble inside cell		any size		none	none
5	Polarizer defect (if Polarizer is used)	Scratch and damage on polarizer, particle on polarizer or between polarizer and glass.	Refer to item 1 and item 2.			
		Bubble, dent and convex	A B C	$\Phi \leq 0.3$ 0.3< $\Phi \leq 0.5$ 0.5< $\Phi$ Total defective point(B,C)	lgnored 2 0 2	Ignored

			Judgement standard			
	Inspection item		Acce	Acceptable number		
		Category	A zone	B zone		
6	Surplus glass	①Stage surplus glas	ss b≦0.3mm			
		glass	Should not influence of	outline dimension and assembling.		
7	MURA	①MURA	not allow the appear is not obvious, the s Note: the principle of installed on the who not find it in the nor Inspection basis: 6% (MURA mainly in t relatively dark will	Naked eye examination: red, green, blue screen does not allow the appearance, black screen requires visual is not obvious, the specific reference limit samples. Note: the principle of closing the sample is to be installed on the whole machine and the end user will not find it in the normal usage scenario. Inspection basis: 6%ND (MURA mainly in the black screen and indoor light is relatively dark will be found, it is recommended to turn off the indoor lighting inspection.)		
		②Point Black / WI point(MURA)	$D \le 0.10$ mm Ignored 0.10mm < $D \le 0.3$ mm, D>0.3mm: Unqualit 2, switch to the red,	; N≦2;		



		Inspection item	Judgement standard
		Component soldering: No cold soldering, short/open circuit, burr, tin ball. The flat encapsulation component position deviation must be less than 1/2 width of the pin (Pic.1); The sheet component deviation: pin deviates from the pad and contact with the near components is not permitted (Pic.2)	Component $\downarrow$ $\downarrow$ $\downarrow$ $\downarrow$ $\downarrow$ $\downarrow$ $\downarrow$ $\downarrow$ $\downarrow$ $\downarrow$
9	FPC defect	lead defect: The lead lack must be less than 1/2of its width; The lead burr must be less than 1/2 of the seam; Impurities connect with the near leads is not permitted	Soldering pad Lead L2>0 Component L1>0
		Connector soldering: Soldering tin is at contact position of the plug and socket is not permitted No foundation is scald Serious cave distortion on plug and socket contact pin is not permitted	bead Base Board Soldering tin is not permit in this area Soldering tin is not permit in this area

## **12.GENERAL PRECAUTIONS**

#### 1.1 HANDING

- (1) When the module is assembled, it should be attached to the system firmly. Be careful not to twist and bent the module.
- (2) Refrain from strong mechanical shock and / or any force to the module. In addition to damage, this may cause improper operation or damage to the module and back-light unit.
- (3) Note that display modules are very fragile and could be easily damaged. Do not press or scratch the surface harder than a HB pencil lead.
- (4) Wipe off water droplets or oil immediately. If you leave the droplets for a long time, straining and discoloration may occur.
- (5) If the display module surface becomes contaminated, breathe on the surface and gently wipe it with a soft dry cloth. If it is heavily contaminated, should be wiped by moisten cloth with isopropyl alcohol or ethyl alcohol solvents, DO NOT with water, ketone type materials (e.g. acetone), aromatic, toluene, ethyl acid or methyl chloride, and so on.
- (6) If the liquid crystal material leaks from the panel, it should be kept away from the eyes or mouth. In case of contact with hands, legs or clothes, it must be washed away thoroughly with soap.
- (7) Use finger-stalls with sort gloves in order to keep display clean during the incoming inspection and assembly process.
- (8) Protection film for polarizer on the module shall be slowly peeled off just before use so that the electrostatic charge can be minimized.
- (9) Do not touch directly conductive parts such as the CMOS LSI pad and the interface terminals with bare hands, therefore operations should be grounded whenever he/she comes into contact with the modules.
- (10) Do not exceed the absolute maximum rating value. (The supply voltage variation, input voltage variation, variation in part contents and environmental temperature, and so on), otherwise the module may be damaged.

#### 1.2 SOLDERING

- (1) Use soldering irons with proper grounding and no leakage.
- (2) For No RoHS Product: soldering temperature is 290~350°C, soldering time is 3~5s; for RoHS Product: soldering temperature is 340~370°C, soldering time is 3~5s.
- (3) If soldering flux is used, be sure to remove any remaining flux after soldering (This does not apply in the case of a non-halogen type of flux).

#### 1.3 STORAGE

- (1) DO NOT leave the module in high temperature and high humidity for a long times, keep the temperature from 0°C to 35°C and relative humidity of less than 60%.
- (2) It is highly recommended to store the module in a dark place. The Liquid crystal is deteriorated by ultraviolet, DO NOT leave it in direct sunlight and strong ultraviolet ray for many hours.